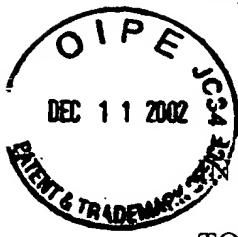


0557-4969-2



IN THE UNITED STATES PATENT & TRADEMARK OFFICE

RE APPLICATION OF

TOMOHIRO NAKAJIMA

: EXAMINER: PHAN, J.

SERIAL NO: 09/552,657

:

RCE FILED: JULY 25, 2002

: GROUP ART UNIT: 2872

FOR: MULTIBEAM SCANNING  
APPARATUS

AMENDMENT

ASSISTANT COMMISSIONER FOR PATENTS  
WASHINGTON, D.C. 20231

SIR:

In response to the Office Action of August 14, 2002, please amend the above-identified application as follows:

IN THE CLAIMS

Please amend Claims 1, 9, 12, 14, and 15 to read as follows:<sup>1</sup>

1. (Twice Amended) A multibeam scan apparatus comprising:

a light source having semiconductor laser diodes and coupling lenses arranged in a main scan direction, the semiconductor laser diodes and coupling lenses being positioned so that light beams emitted by the semiconductor laser diodes are emitted on slanting optical axes to substantially cross each other at a point;

12/12/2002 SDENB0B1 00000043 09552657

01 FC:1201

252.00 0P

<sup>1</sup>A marked-up copy of the amendments is attached hereto.